

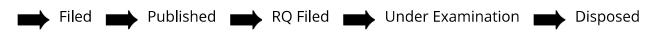
Office of the Controller General of Patents, Designs & Trade Marks Department of Industrial Policy & Promotion, Ministry of Commerce & Industry, Government of India

(http://ipindia.nic.in/index.htm)



GEOGRAPHICALINDICATIONS					
Application Details					
201941030859					
ORDINARY APPLICATION					
31/07/2019					
APPLICANT NAME 1 . DR. CHUKKA SANTHAIAH (ASSOCIATE PROFESSOR, CSE DEPT.) 2 . MR. PITTY NAGARJUNA 3 . DR. NALUGURU UDAYA KUMAR 4 . DR.R.POONKUZHALI 5 . PROF.(DR.) S. B. CHORDIYA 6 . DR. YASHPAL SINGH					
I- IMAGE: INTELLIGENT IMAGE PROCESSING TECHNOLOGY TODETECT THE OBJECT					
MECHANICAL ENGINEERING					
dr.bksarkar2003@yahoo.in					
chukka.santh@gmail.com					
09/08/2019					

Application Status					
APPLICATION STATUS Awaiting Request for Examination					
			View Documents		



In case of any discrepancy in status, kindly contact ipo-helpdesk@nic.in

Home (http://ipindia.nic.in/index.htm) About Us (http://ipindia.nic.in/about-us.htm) Who's Who (http://ipindia.nic.in/whos-who-page.htm)
Policy & Programs (http://ipindia.nic.in/policy-pages.htm) Achievements (http://ipindia.nic.in/achievements-page.htm) RTI (http://ipindia.nic.in/right-to-information.htm)
Feedback (https://ipindiaonline.gov.in/feedback) Sitemap (shttp://ipindia.nic.in/itemap.htm) Contact Us (http://ipindia.nic.in/contact-us.htm)
Help Line (http://ipindia.nic.in/helpline-page.htm)

Skip to Main Content Screen Reader Access (screen-reader-access.htm)



(http://ipindia.nic.in/index.htm)



(http://ipindia.nic.in/index.htm)

Patent Search

Invention Title	I- IMAGE: INTELLIGENT IMAGE PROCESSING TECHNOLOGY TODETECT THE OBJECT
Publication Number	32/2019
Publication Date	09/08/2019
Publication Type	INA
Application Number	201941030859
Application Filing Date	31/07/2019
Priority Number	
Priority Country	
Priority Date	
Field Of Invention	COMPUTER SCIENCE
Classification (IPC)	G06Q20/00

Inventor

Name	Address	Country	Nationality
DR. CHUKKA SANTHAIAH (ASSOCIATE PROFESSOR, CSE DEPT.)	INSTITUTE OF AERONAUTICAL ENGINEERING, DUNDIGAL ROAD, DUNDIGAL, HYDERABAD, 500043	India	India
MR. PITTY NAGARJUNA	SENIOR SCIENTIFIC OFFICER, INDIAN INSTITUTE OF SCIENCE, BENGALORE-560012	India	India
DR. NALUGURU UDAYA KUMAR	MARRI LAXMAN REDDY INSTITUTE OF TECHNOLOGY AND MANAGEMENT, DUNDIGAL, HYDERABAD, 500043	India	India
DR.R.POONKUZHALI	SCHOOL OF ELECTRONIC ENGINEERING, VIT UNIVERSITY, GORBACHEV RD, VELLORE, 632014	India	India
PROF.(DR.) S. B. CHORDIYA	SURYADATTA INSTITUTE OF MANAGEMENT & MASS COMMUNICATION (SIMMC) SR. NO: 342, BAVDHAN, PUNE-411021	India	India
DR. YASHPAL SINGH	FL NO:104, WING-A, NEAR DAULAT PETROL PUMP, BHUGAON, BAVDHAN, PUNE-15	India	India

Applicant

Name	Address	Country	Nationality
DR. CHUKKA SANTHAIAH (ASSOCIATE PROFESSOR, CSE DEPT.)	INSTITUTE OF AERONAUTICAL ENGINEERING, DUNDIGAL ROAD, DUNDIGAL, HYDERABAD	India	India
MR. PITTY NAGARJUNA	SENIOR SCIENTIFIC OFFICER, INDIAN INSTITUTE OF SCIENCE, BENGALORE	India	India
DR. NALUGURU UDAYA KUMAR	MARRI LAXMAN REDDY INSTITUTE OF TECHNOLOGY AND MANAGEMENT, DUNDIGAL, HYDERABAD	India	India
DR.R.POONKUZHALI	SCHOOL OF ELECTRONIC ENGINEERING, VIT UNIVERSITY, GORBACHEV RD, VELLORE	India	India
PROF.(DR.) S. B. CHORDIYA	SURYADATTA INSTITUTE OF MANAGEMENT & MASS COMMUNICATION (SIMMC) SR. NO: 342, BAVDHAN, PUNE-411021	India	India
DR. YASHPAL SINGH	FL NO:104, WING-A, NEAR DAULAT PETROL PUMP, BHUGAON, BAVDHAN, PUNE-15	India	India

Abstract:

[55] My Invention "I- Image" The disclosure reveals a intelligent computer vision technique to measure flank and crater wear of a deep single point cutting tool. This advanced direct tool wear measurement method uses a intelligent microscope mounted high vision camera to acquire an image(2-D, 3-D image) of the tool. Special high lighting of a face of the tool shows contrast of the wear region in the image. The image analysis is based on an interactive procedure utilizing a general purpose image(2-D, 3-D) processing system. Intelligent computer program calculates 12 parameters to characterize flank and crater wear.

Complete Specification

Claims:WE CLAIMS

[52]

- 1. My Invention "I- Image" The disclosure reveals a intelligent computer vision technique to measure flank and crater wear of a deep single point cutting tool. This advanced direct tool wear measurement method uses a intelligent microscope mounted high vision camera to acquire an image(2-D, 3-D image) of the tool. Special high lighting of a face of the tool shows contrast of the wear region in the image. The image analysis is based on an interactive procedure utilizing a general purpose image(2-D, 3-D) processing system. Intelligent computer program calculates 12 parameters to characterize flank and crater wear.
- 2. According to claims 1# the invention is to provide a system which enables ready determination of an appropriate brightness threshold value for use when the worn portion of a tool is to be displayed as a visible image.
- 3. According to claims 1# the invention is to provide an image processing system comprising means to take the image of an ITV camera of the worn portion of a tool together with surrounding portions, defining a window framing a region of said image corresponding to the worn portion and portions other than the worn portion, measuring the brightness distribution within the region framed by the window, comparing said brightness distribution with the brightness distribution within a region framed by a window expanded to frame the region framed by said window together with additional portions other than the worn portion, setting a brightness threshold value at a value falling between a region wherein variation of the brightness distribution occurs and a region in which it does not occur, and digitizing image information in the binary system using the so-obtained threshold value.
- 4....According to claims 1# the invention is to provide, therefore, since the brightness distribution is measured for a plurality of images including the worn portion of the

View Application Status



Terms & conditions (http://ipindia.gov.in/terms-conditions.htm) Privacy Policy (http://ipindia.gov.in/privacy-policy.htm) Copyright (http://ipindia.gov.in/copyright.htm) Hyperlinking Policy (http://ipindia.gov.in/sccessibility.htm) Archive (http://ipindia.gov.in/archive.htm) Archive (http://ipindia.gov.in/archive.htm) Contact Us (http://ipindia.gov.in/contact-us.htm) Help (http://ipindia.gov.in/help.htm)

Content Owned, updated and maintained by Intellectual Property India, All Rights Reserved.

Page last updated on: 26/06/2019

FORM 1	(FOR OFFICE USE ONLY)	
THE PATENTS ACT 1970 (39 of 1970)	Application No:	
&	Filing Date	
The Patents Rules, 2003	Amount of Fees Paid:	
APPLICATION FOR GRANT OF PATENT	CBR NO:	
(See sections 7, 54 & 135 and rule 20(1)	Signature:	
1. APPLICANTS REFERENCE /		
IDENTIFICATION NO. (ASALLOTTED BY OFFICE)		

2. TYPE OF APPLICATION [Please tick (✓) at the appropriate category]

Ordinary (🗸	Ordinary (✓) Co		Ordinary (/) Convention ()		PCT-NP()	
Divisional	Patent of	Divisiona	Patent of	Divisiona	Patent of	
()	Addition ()	1	Addition ()	1()	Addition ()	
		()				

3A. APPLICANT(S):

JA. AT LICAN (S).					
Name	Country of	Nationality	Address		
	Residence				
DR. CHUKKA	INDIA	AN INDIAN	INSTITUTE OF AERONAUTICAL		
SANTHAIAH (ASSOCIATE		NATIONA	ENGINEERING, DUNDIGAL ROAD, DUNDIGAL,		
PROFESSOR, CSE DEPT.)			HYDERABAD, TELANGANA 500043, INDAI		
			e-mail:chukka.santh@gmail.com		
MR. PITTY NAGARJUNA	INDIA	AN INDIAN	SENIOR SCIENTIFIC OFFICER, INDIAN		
		NATIONAL	INSTITUTE OF SCIENCE, BENGALORE-560012,		
			KARNATAKA, INDIA		
			e-mail: nagarjuna@iisc.ac.in		
DR. NALUGURU UDAYA	INDIA	AN INDIAN	MARRI LAXMAN REDDY INSTITUTE OF		
KUMAR		NATIONAL	TECHNOLOGY AND MANAGEMENT, DUNDIGAL,		
(DEPT. ECE)			HYDERABAD, TELANGANA 500043, INDIA		
			E-MAIL: joyudaya@gmail.com		
DR.R.POONKUZHALI	INDIA	AN INDIAN	SCHOOL OF ELECTRONIC ENGINEERING, VIT		
(ASSOCIATE		NATIONAL	UNIVERSITY, GORBACHEV RD, VELLORE, TAMIL		
PROFESSOR)			NADU 632014,INDIA ,E-MAIL:		
			rpoonkuzhali@vit.ac.in, PAN NO: AKQPP8683E.		
PROF.(DR.) S.B.	INDIA	AN INDIAN	SURYADATTA INSTITUTE OF MANAGEMENT &		
CHORDIYA		NATIONAL	MASS COMMUNICATION (SIMMC)		
(DIRECTOR-SIMMC-			SR. NO: 342, BAVDHAN, PUNE-411021, MH,		
CAMPUS)			INDIA		
DR. YASHPAL SINGH	INDIA	INDIA	FL NO:104, WING-A, NEAR DAULAT PETROL		
			PUMP, BHUGAON, BAVDHAN, PUNE-15, MH,		
			INDIA		

3B. CATEGORY OF APPLICANT [Please tick (✓) at the appropriate category]

	 . ,	11 1	ני ט
Natural Person (✓)	Other than Natural Person ()		
			1
	Small Entity ()	Startup (Others()
)	

4. INVENTOR(S): [Please tick (✓) at the appropriate category]

Are all the inventor(s)	Yes (✓)	No ()
same as the applicant(s)		
named above?		

If "No", furnish the details of the inventor(s) N.A

Name	Nationality	Country of Residence	Address
NA	NA	NA	NA

5. TITLE OF THE INVENTION:

I- Image: INTELLIGENT IMAGE PROCESSING TECHNOLOGY TODETECT THE OBJECT

6. AUTHORISED REGISTERED		NA
PATENT AGENT(S)		
ADDITIONAL PATENT AGENTS	NA	

7. ADDRESS FOR SERVICE OF APPLICANT/ PATENT	Mobile No.: 8059794469
AGENT(S) IN INDIA	E-mail:
DR. CHUKKA SANTHAIAH (ASSOCIATE PROFESSOR, CSE DEPT.)	dr.bksarkar2003@yahoo.in
Address:	
INSTITUTE OF AERONAUTICAL ENGINEERING, DUNDIGAL ROAD,	
DUNDIGAL, HYDERABAD, TELANGANA 500043, INDAI	
e-mail:chukka.santh@gmail.com	

8. IN CASE OF APPLICATION CLAIMING PRIORITY OF APPLICATION FILED IN CONVENTION COUNTRY, PARTICULARS OF CONVENTION APPLICATION: N.A

Country	Appln. Number	Filing Date	Name of the Applicant	Title of the Invention	IPC (as classified in the convention country)
					oon vontion ooding
NA	NA	NA	NA	NA	NA

9. IN CASE OF PCT NATIONAL PHASE APPLICATION, PARTICULARS OF INTERNATIONAL APPLICATION FILED UNDER PATENT CO-OPERATION TREATY (PCT):

International application	International filing date as allotted by the
number	receiving office.
NA	NA

10. IN CASE OF DIVISIONAL APPLICATION FILED UNDER SECTION 16, PARTICULARS OF ORIGINAL (FIRST) APPLICATION: N.A

Original (first) application number	Date of filing of Original (first) application
N.A.	N.A.

11.IN CASE OF PATENT OF ADDITION FILED UNDER SECTION 54, PARTICULARS OF MAIN APPLICATION OR PATENT: N.A

Main application / patent Number	Date of filing of main application
N.A.	N.A.

12. DECLARATIONS:

(i) **Declaration by the Inventor:**

(In case the applicant is an assignee: the inventor(s) may sign herein below or the applicant may upload the assignment or enclose the assignment with this application for patent or send the assignment by post/electronic transmission duly authenticated within the prescribed period).

We, the above named inventor are the true & first inventor for this invention and declare that the applicant herein is my assignee or legal representative:

NA

(ii) Declaration by the applicant/s in the convention country:

(In case the applicant in India is different than the applicant in the convention country: the applicant in the convention country may sign herein below or applicant in India may upload the assignment from the applicant in the convention country or enclose the said assignment with this application for patent or send the assignment by post/electronic transmission duly authenticated within the prescribed period)

I/ We, the applicant(s) in the convention country declare that the applicant(s) herein is/ are my/ our assignee or legal representative. : N.A.

(iii) **Declaration by the applicants:**

We, the applicants hereby declare that: -

- 1. We are in possession of the above-mentioned invention.
- 2. The **Complete Specification** relating to the invention is filed with this application.
- 3. The invention as disclosed in the specification uses the biological material from India and the necessary permission from the competent authority shall be submitted by us before the grant of patent to us: **N.A.**
- 4. There is no lawful ground of objection to the grant of the patent to me/ us.
- 5. We are the assignees or legal representatives of true and first inventors:
- 6. The application or each of the applications, particulars of which are given in Para 8 was the first application in convention country/countries in respect of our invention: **N.A.**
- 7. We claim the priority from the above mentioned application filed in convention country/ countries and state that no application for protection in respect of the invention had been made in a convention country before that date by us or by any person from which we derive the title: YES
- 8. Our application in India is based on international application under Patent Cooperation Treaty (PCT) as mentioned in Para-9: **N.A.**

- 9. The application is divided out of our application particulars of which is given in Para-10 and prays that this application may be treated as deemed to have been filed on N.A. Under sec.16 of the Act: N.A.
- 10. The said invention is an improvement in or modification of the invention particulars of which are given in Para-11: **N.A**.

FOLLOWING ARE THE ATTACHMENTS WITH THE APPLICATION

(a) **Form 2**

Item	Details	Fee	Remarks
Complete	No. of pages:		
specification) #			
	No. of claims:		
Claim(s)	No. of pages:		
Abstract	No. of pages:		
Drawing(s)	No. of drawings:		
	No. of pages:		

- # In case of a complete specification, if the applicant desires to adopt the drawings filed with his provisional specification as the drawings or part of the drawings for the complete specification under rule 13(4), the number of such pages filed with the provisional specification are required to be mentioned here.
 - 1. Complete specification (in conformation with the international application)/ as amended before the International Preliminary Examination Authority (IPEA), as applicable (2 copies) **N.A**
 - 2. Sequence listing in electronic form N.A.
 - 3. Drawings (in conformation with the international application)/as amended before the International Preliminary Examination Authority (IPEA), as applicable (2 copies) **N.A**
 - 4. Statement and Undertaking on Form-3
 - 5. Declaration of Inventor ship on Form-5
 - 6. Request For Publication Form9, 2750.Rs
 - 7. Form18 Examination Request, 4400.Rs
 - 8. Power of Authority
 - 9. Other Form 4 to 31 According to needed can fill.

Total fee Rs	/ -	in Cash / Banker's Cheque /Bank Draf	t bearing
No			
Date	on	. Bank.	

We hereby declare that to the best of my knowledge, information and belief the facts and matters stated herein are correct and I request that a patent may be granted to me for the said invention.

Dated this day of......28/7/19

DR. CHUKKA SANTHAIAH (ASSOCIATE PROFESSOR, CSE DEPT.)
MR. PITTY NAGARJUNA
DR. NALUGURU UDAYA KUMAR (DEPT. ECE)
DR.R.POONKUZHALI (ASSOCIATE PROFESSOR)
PROF.(DR.) S. B. CHORDIYA (DIRECTOR-SIMMC-CAMPUS)

DR. YASHPAL SINGH

To, The Controller of Patent, The Patent Office, at